

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/735,860		TANAYA, HIDEO	
				Examiner		Art Unit	
				Jaydi A. Aguirrechea		2834	

ORIGINAL				CROSS REFERENCE(S)									
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)										
310	370	333	200										
INTERNATIONAL CLASSIFICATION													
H	0	3	H	9/21									
H	0	1	L	41/04									
H	0	1	L	41/08									
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J. AGUIRRECHEA 8/16/05 (Assistant Examiner) (Date)				DARREN SCHUBERG SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) (Date) 8/19/05				Total Claims Allowed: 12					
Hawkins 8/24/5 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s)		O.G. Print Fig.			
1		31		61		91		121		151		181	
2		32		62		92		122		152		182	
3		33		63		93		123		153		183	
4		34		64		94		124		154		184	
5		35		65		95		125		155		185	
6		36		66		96		126		156		186	
7		37		67		97		127		157		187	
8		38		68		98		128		158		188	
9		39		69		99		129		159		189	
10		40		70		100		130		160		190	
11		41		71		101		131		161		191	
12		42		72		102		132		162		192	
13		43		73		103		133		163		193	
14		44		74		104		134		164		194	
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16		46		76		106		136		166		196	
17		47		77		107		137		167		197	
18		48		78		108		138		168		198	
19		49		79		109		139		169		199	
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22		52		82		112		142		172		202	
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24		54		84		114		144		174		204	
25		55		85		115		145		175		205	
26		56		86		116		146		176		206	
27		57		87		117		147		177		207	
28		58		88		118		148		178		208	
29		59		89		119		149		179		209	
30		60		90		120		150		180		210	